## FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMME PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT(S)

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	(Use several sheets if necessary)

Submitted to the PTO: May 31, 2005

ATTY DOCKET NO. 03500.017930

**APPLICANTS** 

TAKEO YAMAZAKI, ET AL.

FILING DATE May 31, 2005 GROUP

To be assigned

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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Sheet 1 of 1

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FORM PTO 1449 (17			ATTY DOCKET NO. APPLICATION NO. 10/537,231				
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LIST OF	REFERENCES CITED BY (Use several sheets if necessary)	APPLICANTS)	TAKEO YAMAZAKI, ET AL	·			
Submitted to the PT		60	FILING DATE May 31, 2005	8	GROUP <b>3753</b>		
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

## FORM PTO 1449 (modified) U.S. DEPARTMEN PATENT AND TR.

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

Submitted to the PTO: August 30, 2006

ATTY DOCKET NO. 03500.017930

APPLICATION NO. 10/537,231

APPLICANTS

TAKEO YAMAZAKI, ET AL.

FILING DATE
May 31, 2005

GROUP **3753** 

Submitted to the PTO: August 30, 2006			May 31, 2005	3	3753		
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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				Y DOCKET NO. APPLICATION NO. 10/537,231			
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